





TPS7H1121-SP SLVSH48A – MAY 2024 – REVISED SEPTEMBER 2024

TPS7H1121-SP 2.25V to 14V Input, 2A, Radiation Hardened Low Dropout (LDO) Linear Regulator

1 Features

Texas

INSTRUMENTS

- Total Ionizing Dose radiation characterized:
 Radiation hardness assurance (RHA)
- availability of 100krad(Si) or 50krad(Si) Single-Event Effects (SEE) Characterized
 - Single-event latch-up (SEL), single-event burnout (SEB), and single-event gate rupture (SEGR) immune to linear energy transfer (LET)
 - 75MeV-cm²/mg
 Single-event functional interrupt (SEFI) characterized to LET = 75MeV-cm²/mg
 - Single-event transient (SET) characterized to LET = 75MeV-cm²/mg
- Wide V_{IN} range: 2.25V to 14V
- 2A maximum output current
- ±1.5% accuracy V_{IN} > 3V over load, and temperature
- ±1.8% accuracy V_{IN} < 3V over load, and temperature
- Soft start (SS) control through an external capacitor
- Open-drain power good (PG) output for power sequencing
- Programmable current limit through an external resistor (CL)
- Optional external control loop compensation
 utilizing the STAB pin
- Excellent load and line transient response
- Plastic packages out gas tested per ASTM E595
- Military (-55°C to 125°C) temperature range

2 Applications

- Satellite electrical power system (EPS)
- Clean analog supply requirements
- Command and data handling (C&DH)
- · Optical imaging payload
- · Radar imaging payload

3 Description

The TPS7H1121 is a radiation-hardened, low dropout linear regulator (LDO) which operates over a wide input voltage range and is optimized for powering devices in a space environment. It is capable of sourcing up to 2A over a 2.25V to 14V input.

The device offers excellent stability and features a programmable current limit with a wide adjustment range. To support the complex power requirements of FPGAs, DSPs, and microcontrollers, the TPS7H1121 provides enable on and off functionality, programmable soft start, and a power good opendrain output.

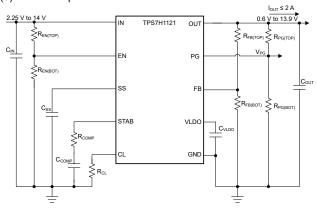
Device Information

| Borroo mormation | | | | | | | |
|--------------------------------|--------------------|-----------------------------------|--|--|--|--|--|
| PART NUMBER ⁽¹⁾ | GRADE | PACKAGE ⁽²⁾ | | | | | |
| 5962R2320301VXC | QMLV-RHA | 22-Pin Ceramic | | | | | |
| TPS7H1121HFT/EM | Engineering sample | 6.21mm × 7.69mm Mass = 415.6mg | | | | | |
| 5962R2320302PYE ⁽³⁾ | QMLP-RHA | 24-Pin Plastic | | | | | |
| TPS7H1121MPWPTSEP (3) | SEP | 4.40mm x 7.80mm Mass = TBD g | | | | | |

(1) For additional information view the Device Options table.

(2) Dimension and mass values are nominal.

(3) Product preview.



Typical Application Circuit





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4 Device Options

| GENERIC PART NUMBER | RADIATION RATING ⁽¹⁾ | GRADE ⁽²⁾ | PACKAGE | ORDERABLE PART NUMBER |
|------------------------|--|----------------------------------|-------------------|----------------------------------|
| | TID of 100krad(Si) RLAT, DSEE free | QMLV-RHA | 22-pin CFP HFT | 5962R2320301VXC |
| TPS7H1121-SP | to 75MeV-cm ² /mg | QMLP-RHA | 24 pin HTSSOP PWP | 5962R2320302PYE ⁽⁴⁾ |
| | None | Engineering model ⁽³⁾ | 22-pin CFP HFT | TPS7H1121HFT/EM |
| TPS7H1121-SEP | TID of 50krad(Si) RLAT, DSEE free to 43MeV-cm ² /mg | Space Enhanced Plastic | 24 pin HTSSOP PWP | TPS7H1121MPWPTSEP ⁽⁴⁾ |

(1) TID is total ionizing dose and DSEE is destructive single event effects. Additional information is available in the associated TID reports and SEE reports for each product.

(2) For additional information about part grade, view SLYB235.

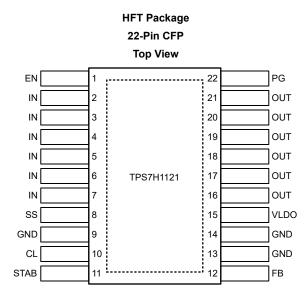
(3) These units are intended for engineering evaluation only. They are processed to a non-compliant flow (such as no burn-in and only 25°C testing). These units are not suitable for qualification, production, radiation testing, or flight use. Parts are not warranted as to performance over temperature or operating life.

(4) Product preview.

3



5 Pin Configuration and Functions



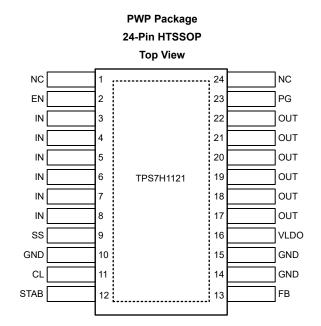


Table 5-1. Pin Functions

| PIN | | PIN | | DESCRIPTION | |
|-------------|---------------------------|---------------------------|-----|---|--|
| NAME | HFT (22) NO. | PWP (24) NO. | 10 | DESCRIPTION | |
| EN | 1 | 2 | I | Enable. Driving this terminal to logic high enables the device; driving the terminal to logic low disables the device. If enable functionality is not required, connect this pin to IN using a resistor divider network, see Section 8.3.2. Do not float this pin. | |
| IN | 2, 3, 4, 5, 6, 7 | 3, 4, 5, 6, 7, 8 | I | Input power. An input capacitor (nominally 10µF) near this pin is recommended. | |
| SS | 8 | 9 | I/O | Soft-start. A minimum 1nF capacitor is required to prevent excessive inrush currents. | |
| GND | 9, 13, 14 | 10, 14, 15 | _ | Ground | |
| CL | 10 | 11 | I | Programmable current limit. A resistor to GND sets the over-current limit activation point. The range of resistor that can be used on the CL terminal to GND is $41.2k\Omega$ to $442k\Omega$. | |
| STAB | 11 | 12 | I/O | Stability pin. This is an output from the internal OTA (operational transconductance) error amplifier to aid in measuring or optimizing the control loop. Standard compensation networks can be applied to the STAB (see Section 8.3.9.1); however, an output capacitance of 22μ F to 220μ F typically achieve high stability margins. | |
| FB | 12 | 13 | I | The output voltage feedback input through voltage dividers. See Section 8.3.1. | |
| NC | _ | 1, 24 | _ | No connect. This pin is not internally connected. It is recommended to connect these pins to GND to prevent charge buildup; however, these pins can also be left open or tied to any voltage between GND and V_{IN} . | |
| VLDO | 15 | 16 | 0 | Output of internal linear regulator, requires a 470nF capacitor connected to ground. | |
| OUT | 16, 17, 18, 19, 20, 21 | 17, 18, 19, 20, 21, 22 | 0 | Output power pin. The regulated output voltage. A single 47μ F tantalum or tantalum polymer capacitor is recommended. Capacitance values between 22μ F and 220μ F are generally supported without additional compensation and wider ranges are supported with use of the STAB pin. See Section 9.2.2.8 for additional information. | |
| PG | 22 | 23 | I/O | Power good indicator. This is an open drain pin. Use a pull-up resistor or a resistor divider (to ensure pin voltage does not exceed 7V) to achieve desired logic level when tied to V_{OUT}. It is recommend to pull down PG to ground if left unused, the PG pin can be left floating if necessary. When the output reaches 95% (typ) of the set output voltage the PG pin is asserted. | |
| Thermal pad | _ | _ | _ | Internally grounded. It is recommended to connect this metal thermal pad to a large ground plane for effective heat dissipation. | |
| Metal lid | Lid | N/A | _ | The lid is internally connected to the thermal pad and GND through the seal ring. | |



6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)⁽¹⁾

| | | MIN | MAX | UNIT |
|----------------------|------------------|--------|------|------|
| | IN, STAB | -0.3 | 16 | V |
| Input voltage | EN, PG | -0.3 | 7.5 | v |
| | FB, CL | -0.3 | 3.3 | V |
| | OUT | -0.6 | 16 | V |
| Output voltage | VLDO | -0.3 | 3.6 | v |
| | SS | -0.3 | 3.3 | V |
| Input current | PG | -0.001 | 0.01 | А |
| Output current | OUT | -3.9 | 3.9 | А |
| Junction temperature | TJ | -55 | 150 | °C |
| Storage temperature | T _{stg} | -65 | 150 | U |

(1) Operation outside the Absolute Maximum Ratings may cause permanent device damage. Absolute Maximum Ratings do not imply functional operation of the device at these or any other conditions beyond those listed under Recommended Operating Conditions. If used outside the Recommended Operating Conditions but within the Absolute Maximum Ratings, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.

6.2 ESD Ratings

| | | | VALUE | UNIT |
|--------------------|-------------------------|---|-------|------|
| V | Electrostatic discharge | Human body model (HBM), per ANSI/ESDA/JEDEC JS-001, all pins ⁽¹⁾ | ±2000 | V |
| V _(ESD) | | Charged device model (CDM), per ANSI/ESDA/JEDEC JS-002, all pins ⁽²⁾ | ±1000 | v |

(1) JEDEC document JEP155 states that 500V HBM allows safe manufacturing with a standard ESD control process.

(2) JEDEC document JEP157 states that 250V CDM allows safe manufacturing with a standard ESD control process.



6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)

| | | MIN | NOM MAX | UNIT |
|----------------------|-----|------|-------------------|------|
| | IN | 2.25 | 14 | |
| Input voltage | EN | 0 | 7 | V |
| | PG | 0 | 7 | |
| Output up the se | OUT | 0.6 | $V_{IN} - V_{DO}$ | V |
| Output voltage | SS | 0 | 1.2 | v |
| Input current | PG | 0 | 2 | mA |
| Output current | OUT | 0 | 2 | А |
| Junction temperature | TJ | -55 | 125 | °C |

6.4 Thermal Information

| | | TPS7H1121-SP | TPS7H1121-SP, -SEP | |
|-----------------------|--|--------------|--------------------|------|
| | THERMAL METRIC ⁽¹⁾ | CFP HFT | PWP (HTSSOP) | UNIT |
| | | 22 PINS | 24 PINS | |
| R _{0JA} | Junction-to-ambient thermal resistance | 30.5 | 26.6 | °C/W |
| R _{0JC(top)} | Junction-to-case (top) thermal resistance | 13.3 | 18 | °C/W |
| $R_{\theta JB}$ | Junction-to-board thermal resistance | 13.5 | 7.7 | °C/W |
| Ψ_{JT} | Junction-to-top characterization parameter | 5 | 0.2 | °C/W |
| Ψ_{JB} | Junction-to-board characterization parameter | 13.3 | 7.7 | °C/W |
| R _{0JC(bot)} | Junction-to-case (bottom) thermal resistance | 4.1 | 0.9 | °C/W |

(1) For more information about traditional and new thermal metrics, see the Semiconductor and IC Package Thermal Metrics application report.



6.5 Electrical Characteristics

Over $2.25V \le V_{IN} \le 14V$, $V_{OUT (set)} \le V_{IN} - 0.5V$, $I_{OUT} = 10$ mA, $C_{OUT} = 47\mu$ F, over operating temperature range ($T_A = -55^{\circ}$ C to 125° C), typical values are at $T_A = 25^{\circ}$ C, unless otherwise noted; includes RLAT at TA = 25° C if sub-group number is present for QML RHA and SEP devices⁽²⁾

| | PARAMETER | Test Con | ditions | SUB- GROUP ⁽¹⁾ | MIN | TYP | MAX | UNIT |
|--|-------------------------------------|---|--|------------------------------|-------|-------|-------|------|
| POWER SUP | PPLIES AND CURRENTS | | | | | | | |
| | | | I _{OUT} = 100mA | 1,2,3 | | 28 | 60 | |
| | | $V_{OUT(set)} = 2.25V$ | I _{OUT} = 250mA | 1,2,3 | | 70 | 141 | |
| | | V _{OUT(measured)} = 98% × V _{OUT(NOM)} | I _{OUT} = 500mA | 1,2,3 | | 150 | 280 | |
| | | | I _{OUT} = 1A | 1,2,3 | | 300 | 570 | |
| | | V _{OUT(set)} = 2.5V | I _{OUT} = 1.5A | 1,2,3 | | 525 | 750 | |
| V _{DO} | Dropout voltage, | V _{OUT(measured)} = 98% × V _{OUT(NOM)} | I _{OUT} = 2A | 1,2,3 | | 570 | 900 | mV |
| 20 | see Figure 7-1 | | I _{OUT} = 100mA | 1,2,3 | | 20 | 50 | |
| | | | I _{OUT} = 250mA | 1,2,3 | | 70 | 100 | |
| | | $3V \le V_{OUT(set)} \le 13.3V$ | I _{OUT} = 500mA | 1,2,3 | | 125 | 180 | |
| | | V _{OUT(measured)} = 98% × V _{OUT(NOM)} | I _{OUT} = 1A | 1,2,3 | | 300 | 340 | |
| | | | I _{OUT} = 1.5A | 1,2,3 | | 325 | 490 | |
| | | | I _{OUT} = 2A | 1,2,3 | | 500 | 700 | |
| | | | RCL = 442kΩ | 1,2,3 | 0.19 | 0.320 | 0.45 | |
| I _{PCL} | Dragrammad ourrant limit | V _{IN} = 3.3V, V _{OUT(short)} = 0.1V | RCL = 174kΩ | 1,2,3 | 0.485 | 0.75 | 1.01 | А |
| | PCL Programmed current limit | | RCL = 82.5kΩ | 1,2,3 | 1.16 | 1.55 | 1.94 | |
| | | | RCL = 41.2kΩ | 1,2,3 | 2.4 | 3 | 3.6 | |
| l _Q | Quiescent current | V _{EN} = 7V, I _{OUT} = 0A | | 1,2,3 | | 8.75 | 15 | mA |
| I _{GND} | ND | V _{EN} = 7V | I _{OUT} = 1A | 1,2,3 | | 10 | 18 | |
| (I _{IN} - I _{OUT}) | Ground current | | I _{OUT} = 2A | 1,2,3 | | 13 | 20 | mA |
| | Internal linear regulator | V _{IN} = 2.25V | | 1,2,3 | 2.05 | 2.2 | 2.25 | |
| VLDO | output voltage | $3V \le V_{IN} \le 14V$ | | 1,2,3 | 2.30 | 2.55 | 2.78 | V |
| I _{SHDN} | Shutdown current | V _{EN} = 0V, I _{OUT} = 0A, V _O | _{UT} = 0V | 1,2,3 | | 380 | 775 | μA |
| I _{FB} | Feedback leakage current | V _{FB} = 0.7V | - | 1,2,3 | | 1 | 15 | nA |
| ACCURACY | | | | | | | | |
| | | 10mA ≤ I _{OUT} ≤ 2A, | $3V \le V_{IN} \le 14V$ | 1,2,3 | -1.5% | | 1.5% | |
| V _{ACC} | Output voltage accuracy | $0.6V \le V_{OUT} \le V_{IN} - V_{DO}$ | $3V \le V_{IN} \le 14V$ T _A = 25°C | 1 | -1.1% | | 1.1% | |
| | | $P_D \leq 3W^{(3)}$ | $2.25V \le VIN \le 3V$ | 1,2,3 | -1.8% | | 1.8% | |
| | | | | 1,2,3 | 0.588 | 0.596 | 0.606 | |
| V _{FB} | Feedback voltage | $3V \le V_{IN} \le 14V$ | T _A = 25°C | 1 | 0.591 | 0.596 | 0.603 | V |
| | | $2.25V \le V_{IN} \le 3V$ | | 1,2,3 | 0.586 | 0.596 | 0.608 | |
| A.Y. / A.Y. | Line regulation, | $3V \le V_{IN} \le 14V$ | | 1,2,3 | | 100 | 650 | |
| $\Delta V_{OUT} / \Delta V_{IN}$ | see Figure 7-2 | $2.25V \le V_{IN} \le 3V$ | | 1,2,3 | | 285 | 1800 | μV/V |
| ΔV _{OUT} / ΔΙ _{ΟUT} | Load Regulation, see Figure 7-3 | $10\text{mA} \le I_{OUT} \le 2\text{A}, V_{IN} =$ | = 5V, V _{OUT} = 3.3V | 1,2,3 | | 4 | 16 | mV/A |
| ENABLE | 1 | 1 | | | | | | |
| V _{EN(rising)} | Enable rising threshold (turn-on) | | | 1,2,3 | 0.565 | 0.605 | 0.625 | V |
| V _{EN(falling)} | Enable falling threshold (turn-off) | | | 1,2,3 | 0.465 | 0.5 | 0.52 | V |
| t _{EN(delay)} | EN propagation delay | EN high to V _{OUT} = 10m | / | 9,10,11 | | 50 | 150 | μs |



6.5 Electrical Characteristics (continued)

Over $2.25V \le V_{IN} \le 14V$, $V_{OUT (set)} \le V_{IN} - 0.5V$, $I_{OUT} = 10$ mA, $C_{OUT} = 47\mu$ F, over operating temperature range ($T_A = -55^{\circ}$ C to 125° C), typical values are at $T_A = 25^{\circ}$ C, unless otherwise noted; includes RLAT at TA = 25° C if sub-group number is present for QML RHA and SEP devices⁽²⁾

| | PARAMETER | Test Conditions G | | SUB- GROUP ⁽¹⁾ | MIN | ТҮР | MAX | UNIT |
|-----------------------------|--|--|--|------------------------------|-------|-------|------|-------------------|
| I _{EN(LKG)} | Enable leakage current | V _{EN} = 7V | V _{EN} = 7V | | · · · | 1 | 30 | nA |
| T _{SD} | Thermal shutdown enter temperature | | | | | 160 | | °C |
| T _{SD} | Thermal shutdown exit temperature | | | | | 130 | | °C |
| POWER GO | OD | I | | | | | | 1 |
| V _{PG_RISE} | Power good rising as percent of V _{OUT} | | | 1,2,3 | 93% | 95% | 97% | |
| V _{PG_FALL} | Power good falling as percent of V _{OUT} | | | 1,2,3 | 88.5% | 91.5% | 94% | |
| V _{PG(OL)} | Power good output low | I _{PG(SINK)} = 2mA | | 1,2,3 | | 90 | 190 | mV |
| V _{IN(MIN_PG)} | $\begin{array}{l} \mbox{Minimum VIN for valid PG} \\ \mbox{(V}_{PG} < 0.5 \mbox{V}) \end{array}$ | | | 1,2,3 | | 0.6 | 0.8 | v |
| I _{PG(LKG)} | Power good leakage | V _{PG} = 7V, V _{FB} = 0.7V | | 1,2,3 | | 0.05 | 2 | μA |
| SOFT STAR | T | 1 | | | | | | |
| I _{SS} | Soft-start current | | | 1,2,3 | 1.4 | 2 | 2.7 | μA |
| | | V _{IN} = 5V, V _{OUT} = 3.3V, | C _{SS} = 1nF | 9,10,11 | 0.22 | 0.35 | 0.48 | |
| t _{SS} | Soft-start time | measured from V _{OUT} = 10mV to PG assert | C _{SS} = 33nF | 9,10,11 | 5.5 | 10 | 14.5 | ms |
| STABILITY | | | | | | | | |
| GM | Gain Margin | V _{IN} = 5V, V _{OUT} = 3.3V, I _C | | | | 24 | | dB |
| PM | Phase Margin | C _{OUT} = 47μF, T _A = 25°C No External Compensati | , on | | | 60° | | |
| NOISE AND | PSRR | | | | | | | |
| | | | f _{ripple} = 100Hz | | | 68 | | |
| | | | f _{ripple} = 1kHz | | | 72 | | |
| PSRR Power-supply rejection | Power-supply rejection ratio | V _{IN} = 5V, V _{OUT} = 3.3V, I _{OUT} = 1A, C _{SS} = 5.6nF | f _{ripple} = 10kHz | | | 51 | | dB |
| | | $f_{ripple} = 100 \text{ kHz}$ | | | | 40 | | |
| | | | f _{ripple} = 1MHz | | | 34 | | |
| V _N | Output noise voltage (bandwidth from 10Hz to 100kHz) | V _{IN} = 5V, V _{OUT} = 3.3V, I _C | _{DUT} = 1A, C _{SS} = 5.6nF | | | 35 | | μV _{RMS} |

Subgroups are applicable for QML parts. For subgroup definitions see Section 6.6. (1)

(2)

See the 5962R23203 SMD for additional information on the QML RHA devices. P_D is the internal power dissipation. When P_D exceeds 3W, the current is lowered to avoid excessive local heating (due to tester (3) limitations).



6.6 Quality Conformance Inspections

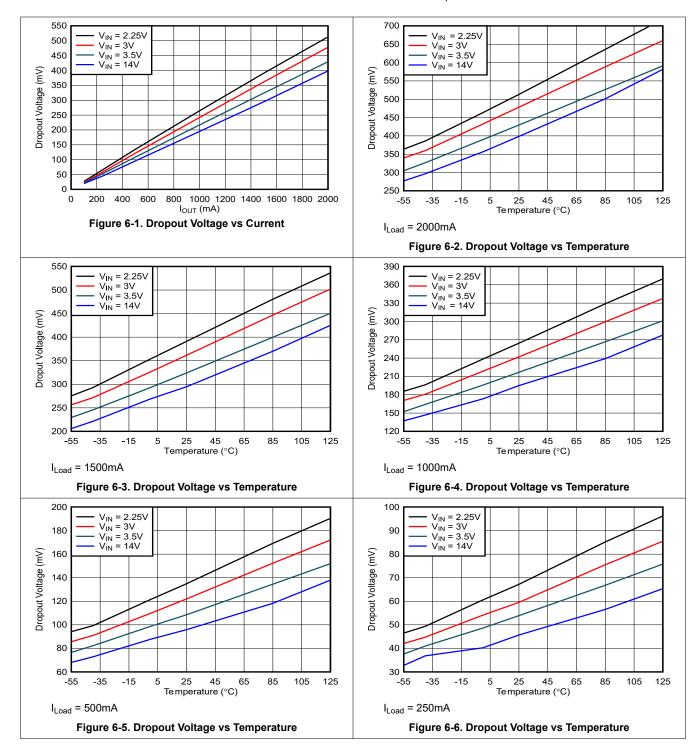
MIL-STD-883, Method 5005 - Group A

| SUBGROUP | DESCRIPTION | TEMPERATURE (°C) |
|----------|---------------------|------------------|
| 1 | Static tests at | 25 |
| 2 | Static tests at | 125 |
| 3 | Static tests at | -55 |
| 4 | Dynamic tests at | 25 |
| 5 | Dynamic tests at | 125 |
| 6 | Dynamic tests at | -55 |
| 7 | Dynamic tests at | 25 |
| 8A | Functional tests at | 125 |
| 8B | Functional tests at | -55 |
| 9 | Switching tests at | 25 |
| 10 | Switching tests at | 125 |
| 11 | Switching tests at | -55 |



6.7 Typical Characteristics

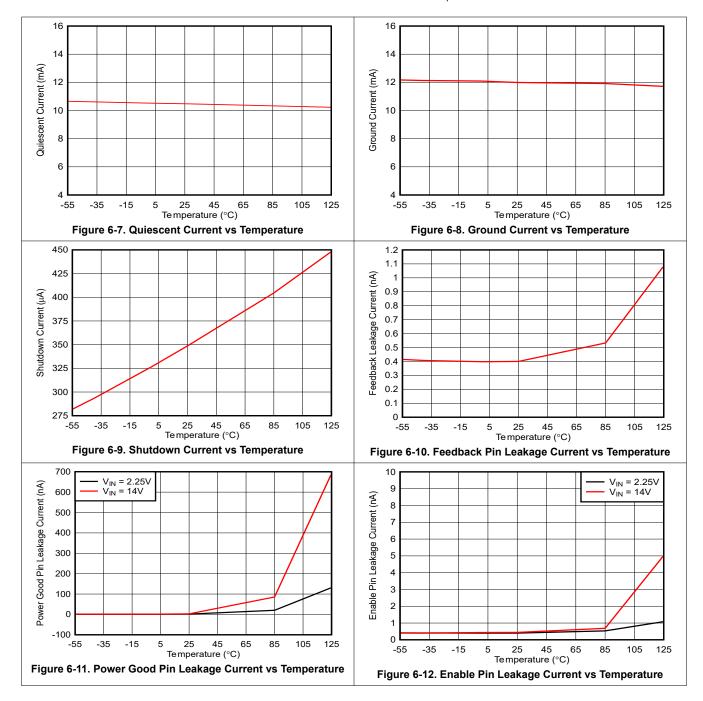
 V_{IN} = 5V, V_{OUT} = 3.3V, T_A = 25°C and C_{SS} = 5.6nF, C_{OUT} = 47µF (TBME476K025LBLC0), when used, the external compensation network is applied as depicted in Section 8.2, no R_{COMP}, no C_{Comp} unless otherwise noted.



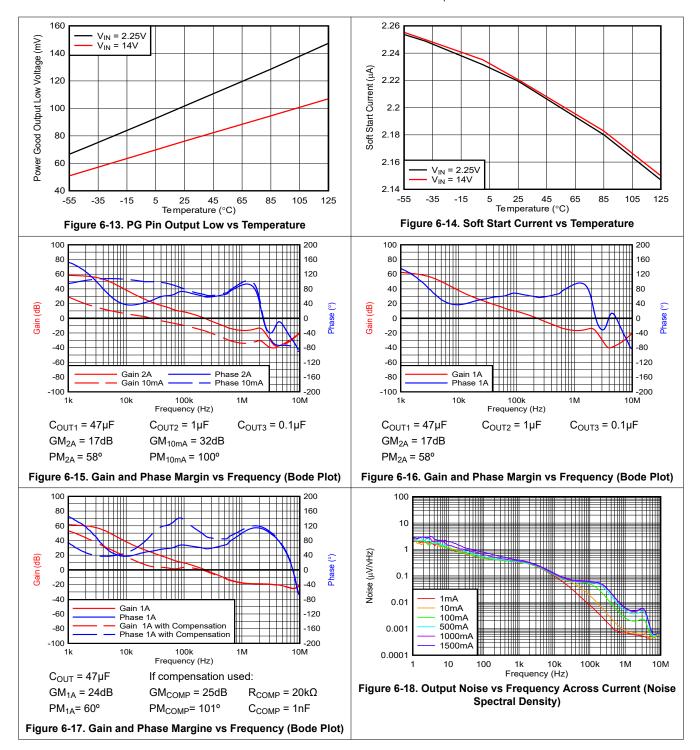




 V_{IN} = 5V, V_{OUT} = 3.3V, T_A = 25°C and C_{SS} = 5.6nF, C_{OUT} = 47µF (TBME476K025LBLC0), when used, the external compensation network is applied as depicted in Section 8.2, no R_{COMP} , no C_{Comp} unless otherwise noted.

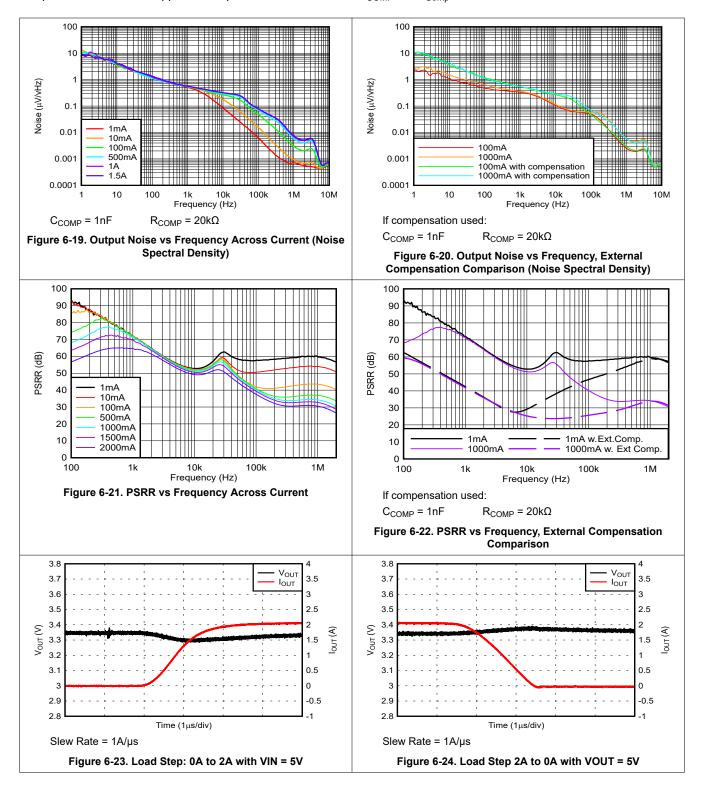


 V_{IN} = 5V, V_{OUT} = 3.3V, T_A = 25°C and C_{SS} = 5.6nF, C_{OUT} = 47µF (TBME476K025LBLC0), when used, the external compensation network is applied as depicted in Section 8.2, no R_{COMP} , no C_{Comp} unless otherwise noted.



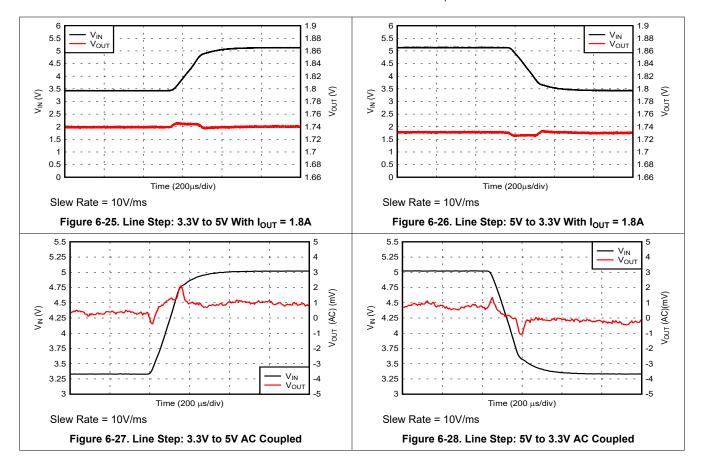


 V_{IN} = 5V, V_{OUT} = 3.3V, T_A = 25°C and C_{SS} = 5.6nF, C_{OUT} = 47µF (TBME476K025LBLC0), when used, the external compensation network is applied as depicted in Section 8.2, no R_{COMP}, no C_{Comp} unless otherwise noted.



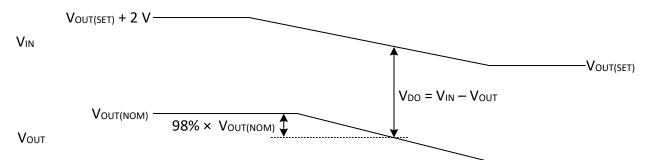


 V_{IN} = 5V, V_{OUT} = 3.3V, T_A = 25°C and C_{SS} = 5.6nF, C_{OUT} = 47µF (TBME476K025LBLC0), when used, the external compensation network is applied as depicted in Section 8.2, no R_{COMP}, no C_{Comp} unless otherwise noted.

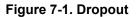


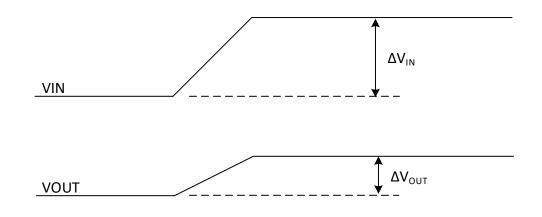


7 Parameter Measurement Information



A. V_{OUT(SET)} is the configured output voltage of the regulator using the feedback resistors, V_{OUT(NOM)} is the measured output voltage. V_{IN} is set 2V above the output (limited to 14V maximum) and is decreased to the output voltage set point (V_{OUT(SET)}). When V_{OUT} falls to 98% of the nominal value (V_{OUT(NOM)}), the dropout voltage is recorded.

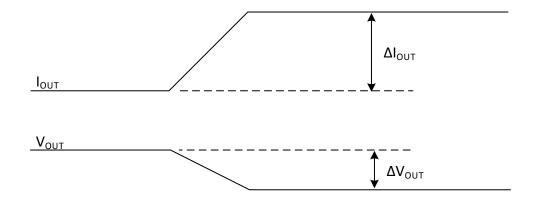




A. $\Delta V_{OUT} / \Delta V_{IN} = 100 \mu V/V$ (typ). This means for a 1V change in V_{IN} ($\Delta V_{IN} = 1V$), there will be a 100 μ V change in V_{OUT} ($\Delta V_{OUT} = 100 \mu$ V). Line regulation is a DC parameter; therefore this waveform can only be considered valid after transients die out or for a slow V_{IN} slew rate.







A. $\Delta V_{OUT} / \Delta I_{OUT} = 4mV/A$ (typ). This means for a 1A change in I_{OUT} ($\Delta I_{OUT} = 1A$), there will be a 4mV change in V_{OUT} ($\Delta V_{OUT} = 4mV$). Load regulation is a DC parameter; therefore this waveform can be considered valid after transients die out or for a slow I_{OUT} slew rate.

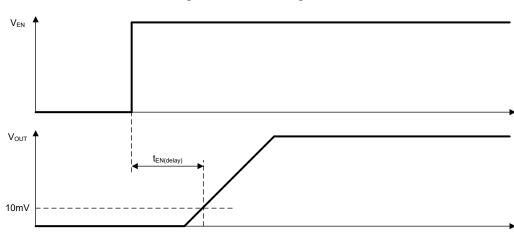


Figure 7-3. Load Regulation

Figure 7-4. Enable Propagation Delay



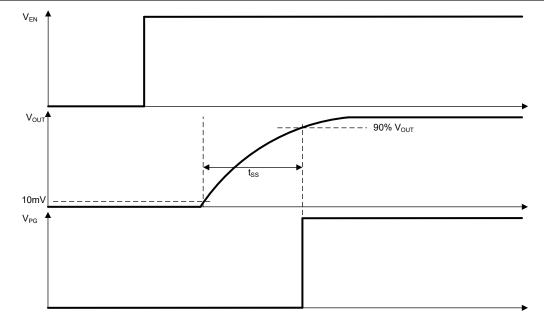


Figure 7-5. Soft Start Time

17

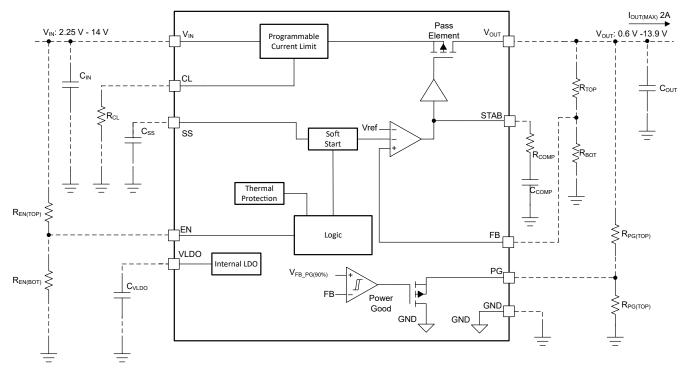


8 Detailed Description

8.1 Overview

The TPS7H1121 (TPS7H1121-SP and TPS7H1121-SEP) is a radiation-hardened low dropout linear regulator (LDO) which operates over a wide range of input voltages. The TPS7H1121 is optimized for powering devices in a space environment by using a PMOS pass element which is capable of sourcing up to 2A over a 2.25V to 14V input.

8.2 Functional Block Diagram



8.3 Feature Description

8.3.1 Adjustable Output Voltage (Feedback Circuit)

The output voltage of the TPS7H1121 can be set to a user-programmable level between 0.6V and 13.9V. Achieve this by using a resistor divider connected between V_{OUT} , FB, and GND terminals. R_{TOP} connected between V_{OUT} and V_{FB} , and R_{BOTTOM} connected between V_{FB} and GND.

Use Equation 5 to determine V_{OUT} .

$$V_{OUT} = \frac{\left(R_{FB(TOP)} + R_{FB(BOT)}\right) \times V_{FB}}{R_{FB(BOT)}}$$
(1)

where

8.3.2 Enable

When the enable pin is low, the device enters shutdown mode and does not regulate the output voltage. Normally, an external resistor divider from V_{IN} to GND is used to feed EN.

Connection of the Enable pin directly to V_{IN} is possible when V_{IN} is below the Recommended Operating level of 7V; if a higher voltage level is to be provided to the Enable pin, then a simple voltage divider can be applied, refer to Equation 2 for resistor sizing guidance at the desired turn-on voltage.

(2)

 $V_{IN(rising)} = V_{EN(rising)} \times (R_{EN TOP} + R_{EN BOT}) / R_{EN BOT}$

Similarly, a $V_{IN(falling)}$ voltage can also be calculated using Equation 3. The $V_{IN(rising)}$ and $V_{IN(falling)}$ can be thought of as configurable UVLO (under voltage-lockout) thresholds.

$$V_{\text{IN}(\text{falling})} = V_{\text{EN}(\text{falling})} \times (R_{\text{EN}_{\text{TOP}}} + R_{\text{EN}_{\text{BOT}}}) / R_{\text{EN}_{\text{BOT}}}$$
(3)

While the TPS7H1121 will turn-on at a voltage of V_{EN} of 0.6V (typ), it is recommended that the final value is above 0.8V. This is to ensure appropriate margin above the enable threshold during normal operation to prevent SEFIs during exposure to heavy ions. This recommendation is achieved by satisfying Equation 4.

$$V_{\text{IN(final)}} \times R_{\text{EN}_{\text{BOT}}} / (R_{\text{EN}_{\text{TOP}}} + R_{\text{EN}_{\text{BOT}}}) = V_{\text{EN(final)}} > 0.8V$$
(4)

Alternatively, the EN pin can be driven directly from a micro-controller or FPGA. The low voltage threshold of the enable pin aids in support of 1.1V, 1.8V, 2.5V, and 3.3V logic levels. Similarly a final V_{EN} above 0.8V for direct logic level driving is recommended (this is typically easily achieved with standard logic levels).

8.3.3 Dropout Voltage V_{DO}

Dropout voltage, V_{DO} , is defined as the input voltage minus the output voltage ($V_{IN} - V_{OUT}$) where the output voltage falls to 98% of the initial value at the indicated current. See Figure 7-1 for the test waveforms used to measure dropout. The dropout voltage is higher at lower values of V_{IN} ; therefore, dropout voltage is specified across different conditions in Section 6.5.

In dropout, the pass transistor is in the ohmic or triode region of operation, and acts as a switch. The dropout voltage indirectly specifies a minimum input voltage greater than the nominal programmed output voltage at which the output voltage is expected to stay in regulation. If the input voltage falls to less than the nominal output regulation, then the output voltage falls as well.

When V_{IN} is below 3V, the error amplifier operates with less headroom versus what is present for a V_{IN} range of 3V to 14V; the reduction in headroom causes higher dropout voltage for V_{IN} voltages less than 3V(see typical dropout performance graphs Figure 6-1 through Figure 6-6).

8.3.4 Output Voltage Accuracy

The TPS7H1121 features an accurate voltage reference, which is essential in minimizing the intrinsic error of the LDO.

Output voltage accuracy specifies minimum and maximum output voltage error, relative to the expected nominal output voltage. The accuracy specification in the Section 6.5 table presents two operating regions, one in which the V_{IN} is above 3V and one when V_{IN} is in the "low-input" voltage region ($2.25V \le V_{IN} \le 3V$).

The ±1.5% specification applies across the complete temperature range of -55° C to 125° C, across the input voltage range of $3V \le V_{IN} \le 14V$, when the dissipated power is $\le 3W$, and up to the full load ($10\text{mA} \le I_{OUT} \le 2A$).

When V_{IN} is below 3V (2.25V \leq V_{IN} \leq 3V), the output voltage accuracy is adjusted to ±1.8%.

A few additional details to the measurement are noted:

- The range of V_{IN}, I_{OUT} and temperature mean the specification applies across all load and temperature combinations. This is accomplished by testing multiple bias conditions that cover various corners.
- Footnote 3 in Section 6.5 specifies that the measurement is done with a power dissipation limit that is limited to a maximum 3W. This is due to tester thermal limitations.
- The test conditions specify a minimum of 10mA and not 0mA for more robust accuracy measurements. However, in a normal application the TPS7H1121 device does not have a minimum load current for stability
- TI does not recommend including the following error terms into the V_{ACC} specification as the following terms are inherently covered by the V_{ACC} parameter:
 - V_{FB} accuracy
 - $\Delta V_{OUT} / \Delta V_{IN}$ (line regulation)
 - $\Delta V_{OUT} / \Delta I_{OUT}$ (load regulation)



V_{OUT} tempco

- The error due to the feedback resistors, such as the specified tolerances can be added to the V_{ACC} specification.
- For additional information on determining accuracy see Section 9.2.2.2.

8.3.5 Output Noise

LDO noise is defined as the internally-generated intrinsic noise created by the semiconductor circuits. The TPS7H1121 output noise is typically $35\mu V_{RMS}$.

When an external compensation network is connected to the STAB pin, the applied network can reduce the loop bandwidth; therefore, the internal circuitry is less capable to minimize internally generated noise. Figure 6-20 shows the noise performance difference when configured with and without an external compensation network (note: $R_{Comp} = 20k\Omega$ and $C_{Comp} = 1nF$).

8.3.6 Power Supply Rejection Ratio (PSRR)

The PSRR (power supply rejection ratio) of the TPS7H1121, is the amount of attenuation of the input noise at V_{IN} , to the output, V_{OUT} . PSRR is mathematically defined in Equation 5.

$$PSRR = 20 \times \log_{10} \left(\frac{V_{IN(AC)}}{V_{OUT(AC)}} \right)$$
(5)

The input noise is generally dominated by the switching ripple of an upstream converter. This noise occurs at the switching frequency and associated harmonics.

When using an external compensation network and the loop bandwidth is reduced, then the overall PSRR diminishes as well. Figure 6-22 illustrates the trade off in a typical application in which the applied compensation network has reduced the loop band-width, but improved system stability ($R_{Comp} = 20k\Omega$, $C_{Comp} = 1nF$).

8.3.7 Soft Start

Connecting a capacitor (C_{SS}) from the SS terminal to GND slows down the output voltage ramp rate. The soft-start capacitor charges up to 1.2V. Equation 6 determines the required soft start capacitor value C_{SS} with a user specified soft -start time t_{SS} .

$$C_{SS} = \frac{t_{SS} \times I_{SS}}{V_{REF}}$$
(6)

where

- t_{SS} = soft-start time
- I_{SS} = 2µA (typ)
- V_{REF} = 1.2V (typ)

See Typical Graph Figure 6-14 for Soft Start Current vs Temperature Performance.

8.3.8 Power Good (PG)

Power Good terminal is an open-drain connection and can be used to sequence multiple LDOs. The PG terminal will be pulled low until the output voltage reaches 95% (typ) of its final level. At that point, the PG pin will be pulled up through the external resistor divider. Since the PG pin is open drain, it can be pulled up to any voltage as long as it does not exceed the recommended maximum of 7V listed in Section 6.5.



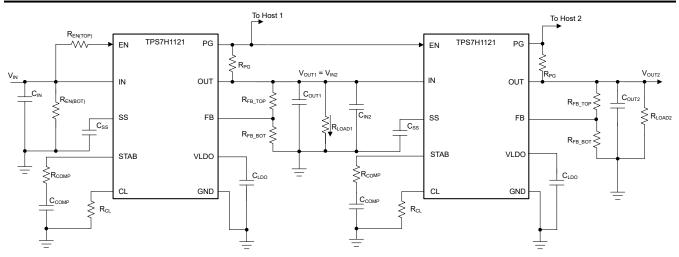


Figure 8-1. Sequenced Power Good

8.3.9 Stability

8.3.9.1 Stability

Traditional stability margins (such as gain margin \geq 6dB and phase margin \geq 50°) for space rated IC's are often more onerous than industrial and consumer electronics. The TPS7H1121 is designed to support a wide range of space rated output capacitors (generally 22µF to 220µF) while maintaining a 6dB gain margin and 50° phase margin without utilizing the included STAB pin for external compensation.

In addition to the TPS7H1121's wide intrinsic stability, the STAB pin may be utilized to insert an external RC compensation network that ties directly to the error amplifier's output. This architecture, as depicted in Figure 8-2, illustrates how an external compensation network is directly inserted prior to the pass element's buffer, which maximizes the efficacy of the inserted RC compensation circuit.

This level of efficacy for an external compensation network enables end-users of the TPS7H1121 to conduct in depth stability analysis and widen stability margins for the applied output load. Additionally, it enables utilization of output capacitors as low as 6.8µF while allowing flexibility in managing low-ESR capacitors.

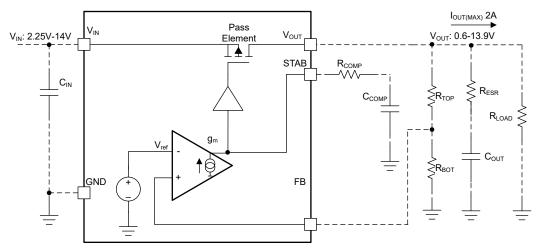


Figure 8-2. Simplified Compensation Schematic

8.3.9.2 STAB Pin

The STAB (stability) pin of the TPS7H1121 is designed to provide direct access to the controller's error amplifier; insertion into the LDO's control circuitry facilitates detailed stability analysis and fine tuning of the LDO's stability performance.

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The TPS7H1121 has a wide envelope in which typical gain and phase margin is in excess of 6dB and 50° (with output capacitance ranging from 22μ F $\leq C_{OUT} \leq 220\mu$ F). However, external compensation is provided via the STAB pin in which the R_{COMP} and C_{COMP} network can be utilized to further optimize the stability performance of the TPS7H1121 if desired. TI recommends that an external network is applied for low C_{OUT} applications or for special concerns in which maximum stability margin is necessary. For further details on how to implement Type II and III Compensation, view section 9.2.2.9 or SLVA662.

8.3.10 Programmable Current Limit

Brick-wall current limit, also known as constant current limit, is shown in Figure 8-3. In this mode, once I_{PCL} is reached and the current limit circuitry has time to respond, the TPS7H1121 LDO enters constant current regulation mode. In other words, the output voltage reduces to whatever value is needed to keep the output current at I_{LIM} . Once the fault is removed the device resumes regulation.

Due to the high power dissipation in brick-wall current limit, there is the possibility that the TPS7H1121 enters thermal shutdown which causes the device to stop regulation until the TPS7H1121 cools enough to exit thermal shutdown.

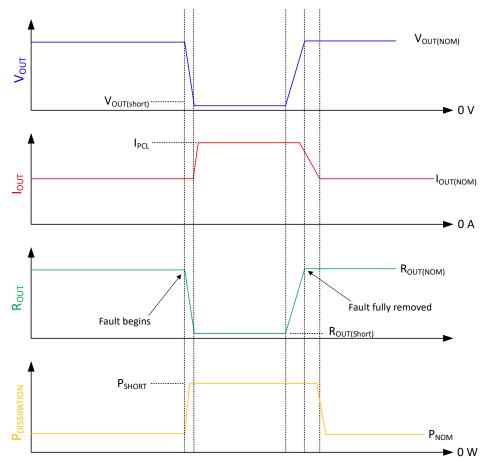


Figure 8-3. Simplified Brick-Wall Current Limit Waveforms

The programmable current limit's accuracy tightens with increased load current; Table 8-1 shows the recommended E96 value with a typical accuracy.

With the stipulated accuracy of the current limit, the programmable current limit resistor R_{CL} needs to be selected to accommodate the negative portion of the accuracy current limit circuitry. Additionally, a 20% headroom margin is recommended to prevent the current limit from intervening during nominal operation. For example an application with a nominal load of 1A can have a minimum programmable current limit setting of



1.4A / 97.6k Ω ; the setting for a 97.6k Ω programmable current limit has a negative accuracy of -25% which leads a minimum intervening current limit of 1.05A.

For example an application with a nominal load of 1A is recommended to have a minimum intervening current of 1.2A; which yields a nominal current limit of 1.6A. Therefore an R_{CL} setting of 80.6k Ω with a negative accuracy of -25% leads to a minimum intervening current limit of 1.2A; which complies with the recommended 20% headroom.

| I | Resistor | |
|--|----------|----------|
| PROGRAMMABLE CURRENT LIMIT SETTING (A) | E96 (kΩ) | ACCURACY |
| 0.32 | 442 | |
| 0.4 | 392 | ±35% |
| 0.5 | 332 | |
| 0.6 | 267 | |
| 0.7 | 205 | |
| 0.75 | 174 | ±30% |
| 0.8 | 169 | 130 /0 |
| 0.9 | 158 | |
| 1 | 143 | |
| 1.1 | 133 | |
| 1.2 | 121 | |
| 1.3 | 110 | |
| 1.4 | 97.6 | |
| 1.5 | 88.7 | |
| 1.55 | 82.5 | ±25% |
| 1.6 | 80.6 | |
| 1.7 | 78.6 | |
| 1.8 | 75 | |
| 1.9 | 71.5 | |
| 2 | 69.8 | |
| 2.1 | 66.5 | |
| 2.2 | 63.4 | |
| 2.3 | 60.4 | |
| 2.4 | 57.6 | |
| 2.5 | 54.9 | 100% |
| 2.6 | 52.3 | ±20% |
| 2.7 | 49.9 | |
| 2.8 | 46.4 | |
| 2.9 | 44.2 | |
| 3 | 41.2 | |

Table 8-1. Recommended Current Limit Setting Resistor

8.3.11 Thermal Shutdown

Upon exceeding the TPS7H1121 thermal shutdown temperature limit, the integrated thermal shutdown circuitry activates to turn-off the device when the die temperature exceeds $T_{SD(enter)}$. As the die cools below $T_{SD(exit)}$, the device resumes regulation. The typical $T_{SD(enter)}$ of 160°C and $T_{SD(exit)}$ of 130°C provides a large hysteresis (30°C typical). The large hysteresis is intended to allow the device to sufficiently cool before attempting to resume regulation.

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8.4 Device Functional Modes

8.4.1 Enable / Disable

The table below shows the device functional modes:

| Table 8-2. I | Device |
|--------------|--------|
| Functional | Modes |

| EN PIN | DEVICE STATUS |
|--------|--------------------|
| High | Regulation mode |
| Low | Shutdown mode |



9 Application and Implementation

Note

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The TPS7H1121-SP LDO linear regulator is targeted space environment applications. This regulator has various features such as low dropout, soft start, output current limit, and error amplifier access via STAB pin.

9.2 Typical Application

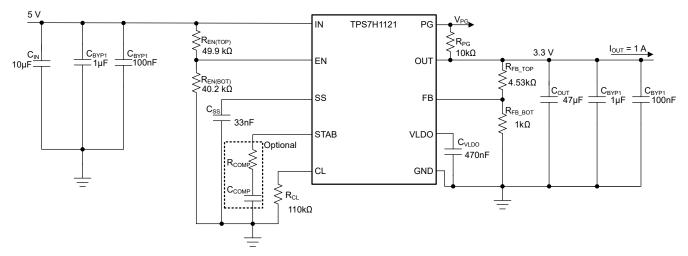


Figure 9-1. Application Schematic

9.2.1 Design Requirements

This example highlights a design using the TPS7H1121 based on its evaluation module. For more details, please refer to the EVM user's guide, TPS7H1121EVM-CVAL Evaluation Module (EVM) User's Guide (SLVUCX9). A few parameters must be known in order to start the design process. These parameters are typically determined at the system level. For this example, we start with the following known parameters:

| Table 9-1. Desig | gn Parameters |
|--|---|
| DESIGN PARAMETER | EXAMPLE VALUE |
| Input voltage | 5V ± 5% |
| Output voltage | 3.3V ± 5% |
| Maximum output current | 1A (typ) |
| V _{IN(turn-on threshold)} | 1.35V (typ) |
| V _{OUT(PG assertion threshold)} | 90% of V _{OUT(final)} (typ), 2.97V |
| Soft start time, t _{SS} | 20ms |
| Minimum phase margin | 50° |
| Maximum gain margin | 6dB |



9.2.2 Detailed Design Procedure

9.2.2.1 Output Voltage Configuration

The output voltage is configured using Equation 1.

Therefore 0.1% feedback resistors are selected with $R_{FB(TOP)} = 1.01k\Omega$ and $R_{FB(BOT)} = 4.53k\Omega$; using resistors with a 1% tolerance is acceptable, however this directly contributes a 1% error to the output voltage.

9.2.2.2 Output Voltage Accuracy

To determine the overall output voltage accuracy, refer to the device voltage accuracy V_{ACC} from the Section 6.5, the top and bottom feedback resistors ($R_{FB(Top)}$ and $R_{FB(BOT)}$).

$$System_{(error)} = V_{ACC} + R_{(error)}$$
(7)

When the input voltage V_{IN} is below 3V, the error amp is operating with a reduced head room such that output accuracy performance is widened to $\pm 1.8\%$; for this example V_{IN} is above 3V, therefore the standard $\pm 1.5\%$ accuracy can be applied.

For the selected 0.1% feedback resistors, the calculated error is shown in Equation 8, this assumes an uncorrelated error and the errors are added as the sum of the resistors' error squared.

$$R_{(error)} = \sqrt[2]{(0.1^2 + 0.1^2)} = \pm 0.14\%$$
(8)

The negative and positive system error's are summed with the results for this example shown below in equations Equation 9 and Equation 10.

$$System_{(neg_error)} = -1.5\% + -0.14\%$$
(9)

$$System_{(pos_error)} = 1.5\% + 0.14\%$$
 (10)

Adding the following errors together results in an accuracy of ±1.64%.

9.2.2.3 Enable Threshold

The desired turn-on threshold is 1.35V. This means that as the V_{IN} rail is turned-on and begins rising, the TPS7H1121 commences turning-on as soon as V_{IN} reaches 1.35V. While this is not enough headroom from V_{IN} to V_{OUT} for final regulation, the regulator initiates start-up and V_{IN} progresses to the final voltage of 5V. If desired, a higher voltage turn-on threshold can be selected (for example, 3.5V), provided the desired voltage is below 7V.

Using Equation 1 and selecting an $R_{EN(TOP)}$ value of 49.9k Ω , the $R_{EN(BOT)}$ can be calculated as shown in Equation 11.

$$R_{EN(BOT)} = \frac{V_{EN(rising)} \times R_{EN(TOP)}}{V_{IN(rising)} - V_{EN(rising)}} = \frac{0.605 V \times 49.9 k\Omega}{1.35 V - 0.605 V} = 40.2 k\Omega$$
(11)

Using E192 resistor values, $R_{EN(BOT)}$ is chosen to be 40.2k Ω .

To comply with the maximum pin voltage for Enable use Equation 4. As shown in Equation 12, $V_{EN(final)} = 2.24V$ which is less than the recommended maximum of 7V and above the recommended minimum final value of 0.8V.

$$V_{EN(final)} = V_{IN(final)} \times \left(\frac{R_{EN(BOT)}}{R_{EN(BOT)} + R_{EN(TOP)}}\right) = \frac{5V \times 40.2k\Omega}{40.2k\Omega + 49.9k\Omega} = 2.24V$$
(12)

9.2.2.4 Soft Start Capacitor

The evaluation module is specified to have a soft start time of t_{SS} of 20ms, the soft start capacitor value can be calculated with Equation 6.

$$C_{SS} = \frac{20 \text{ ms} \times 2 \,\mu\text{A}}{1.2 \text{ V}} = 33.3 \,\text{nF}$$
(13)





Therefore a 33nF ceramic capacitor is selected to configure the soft start time.

9.2.2.5 Programmable Current Limit Resistor

The evaluation module is populated with a current limit setting resistor to provide a I_{lim} = 3A; to configure a lower current limit see Table 8-1.

9.2.2.6 Characterization of Overcurrent Events that Exceed Thermal Limits

High power overcurrent events are characterized by duration, the input and output voltage they occur at, and the resulting current. In these high power overcurrent conditions, the dissipated power in the pass element becomes much greater than nominal operating conditions. Depending on the specific overcurrent conditions, the device heats up until reaching thermal shutdown. However, depending on the specific overcurrent event, the device may heat faster than the thermal shutdown circuitry can respond.

Table 8-1 specifies resistors values for a desired current limit setting and the anticipated accuracy of the programmable current limit at the specified setting; 3A is a recommended maximum programmable current limit setting as the 20% accuracy has a maximum current limit of 3.6A, which is below the Absolute Maximum rating of 3.9A.

The magnitude of the over-current condition intensifies as a function of the V_{IN} - V_{OUT} differential and pulse width (for faults to be evaluated as DC a 1s pulse can be used). By combining the input and output voltage differential, fault pulse width, and programmable current limit setting, a recommended programmable current limit protection area is derived as shown in Figure 9-2 which was characterized using validation hardware for the TPS7H1121 (ceramic package) under laboratory ambient conditions ($T_A = 25^{\circ}$ C). The effective thermal resistance of the thermal pad is calculated to be $R_{TH(PCB)} = 5^{\circ}$ C/W (taking into account thermal via diameter, spacing, and board layers), and the programmable current limit I_{PCL} was set for the maximum allowable current of 3.6A. Applied faults of a pulse width of 10ms, 100ms and 1s were applied until the device was no longer functional; the applied voltage and programmed current were then adjusted lower on subsequent units until the curve was determined.

The depicted curve is very dependent on assumed ambient temperatures, package thermal resistance, PCB thermal resistances and nature of the applied short; the curve below is only applicable for the ceramic unit and the validation hardware utilized.

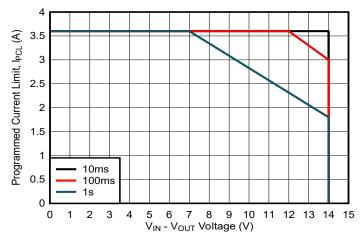


Figure 9-2. Programmable Current Limit Protection Area

9.2.2.7 Power Good Pull Up Resistor

TI recommends to use a pullup resistor between $10k\Omega$ to $100k\Omega$; the evaluation module is configured with $10k\Omega$.

9.2.2.8 Capacitors

TPS7H1121 may use of a combination of tantalum and ceramic capacitors to achieve good volume to capacitance ratio. Table 9-2 highlights some of the supported capacitors. TI recommends to follow proper



derating guidelines as recommended by the capacitor manufacturer based upon output voltage and operating temperature.

TI recommends to use a polymer or tantalum capacitor along with a 0.1μ F and 1μ F ceramic capacitors implemented as bypass capacitors. The device is stable for input and output tantalum, polymer or ceramic X7R capacitor values or networks with bulk capacitance's ranging from 6.8μ F to 880μ F (some values within this range may require the use of external compensation). However, the dynamic performance of the device varies based on load conditions, the capacitor values used (including ESR) and utilization of the external compensation STAB pin. Bulk output capacitance less than 22μ F and capacitance exceeding 220μ F, should generally use an external compensation network applied to the STAB pin to achieve robust stability margins. Thorough stability analysis should always be performed to ensure that requisite stability margins are attained across the entirety of the mission profile.

Bulk output capacitor ESR is significantly affects system stability; the TPS7H1121 was designed to achieve wide gain and phase margins with tantalum or polymer surface mount capacitors with low ESR. Ceramic capacitors are also supported, however ceramic capacitors have lower output capacitance and ESR such that an external compensation network may be necessary to achieve stability targets.

| CAPACITOR PART NUMBER | CAPACITOR DETAILS (CAPACITOR, VOLTAGE, ESR @ 100kHz, Case Size) | ТҮРЕ | VENDOR |
|-----------------------|---|--------------------|--------|
| TES226K035 | 22μF, 35V, 43mΩ, 7343 | Tantalum - MnO2 | AVX |
| TBME476K025LBLC9 | 47μF, 25V, 65mΩ, 7343 | Tantalum - MnO2 | AVX |
| T540D227K010AH | 220μF, 10V, 24mΩ, 7343 | Tantalum - Polymer | Kemet |

| Table 9-2. TPS7H1121 Capacitors |
|---------------------------------|
|---------------------------------|

9.2.2.8.1 Hybrid Output Capacitor Network

The recommendation for the TPS7H1121 is to utilize ceramic bypass capacitors with a tantalum bulk capacitor. The combination of a tantalum and ceramic capacitor forms a hybrid network capacitor; see application report How to Calculate the Load Pole and ESR Zero When Using Hybrid Output Capacitors (SLVAE26) for how to analytically implement and assess the applied output capacitor network.

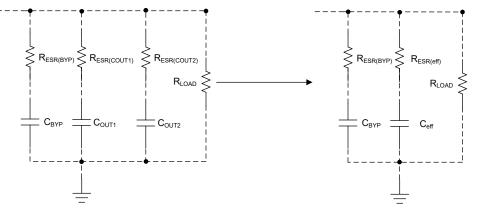


Figure 9-3. Recommended Hybrid Output Capacitor Network Simplification

TI recommends when conducting analytical analysis of the output capacitor network to only combine capacitors and the associated parasitic parameters which are identically specified (combine identical tantalums, keep bypass caps and tantalum caps distinct from each other in analysis). In the figure above, capacitors C_{OUT1} and C_{OUT2} are combined into effective capacitance and ESR of C_{eff} and R_{eff} with the bypass cap C_{BYP} being excluded.



9.2.2.9 Frequency Compensation

Applying a simple RC compensation network to the STAB pin as optionally depicted in Figure 9-1 enables the end user to optimize the phase and gain margin of the system's stability.

The addition of this RC compensation network introduces 2 poles and 1 zero to the system. Firstly, a low frequency pole is present which can be approximated in more detailed analytical analysis.

The compensation pole frequency, $f_{p(COMP)}$, is approximated using Equation 14.

$$f_{p(COMP)} = \frac{C_{COMP} + C_{OTA}}{2\pi \times R_{COMP} \times C_{COMP}}$$
(14)

where

• C_{OTA} = 100pF (typical sim)

The compensation zero frequency, $f_{z(COMP)}$, is approximated by Equation 15.

$$f_{z(COMP)} = \frac{1}{2\pi \times R_{COMP} \times C_{COMP}}$$
(15)

The open loop gain A_{OL} is approximated by Equation 16.

$$A_{OL} = g_{m(OTA)} \times R_{OTA} \tag{16}$$

where

- $g_{m(OTA)} = 5mS$ (typical sim)
- $R_{OTA} = 220 k\Omega$ (typical sim)



9.3 Power Supply Recommendations

This device is designed to operate with an input voltage supply of up to 14V. The minimum input voltage must provide adequate headroom greater than the dropout voltage for the device to have a regulated output. If the input supply is noisy, additional input capacitors with low ESR can help improve the output noise performance.

9.4 Layout

9.4.1 Layout Guidelines

- For best performance, all traces should be as short as possible.
- Use wide traces for IN, OUT, and GND to minimize the parasitic electrical effects.
- Place the bulk output capacitors (generally tantalum or tantalum polymer) near the OUT pins of the device.
 If a ceramic output capacitor is used, place it near the point of load.

9.4.2 Layout Example

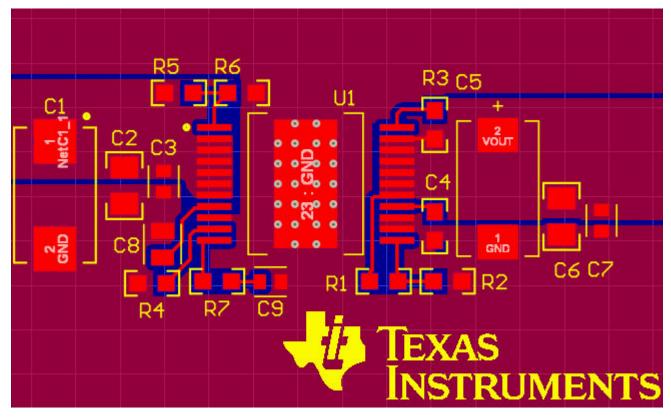


Figure 9-4. Printed Circuit Board Layout Example



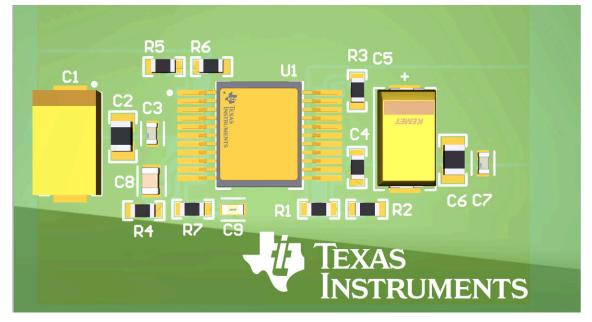


Figure 9-5. Printed Circuit Board Layout Example: 3D View



10 Device and Documentation Support

10.1 Device Support

10.1.1 Third-Party Products Disclaimer

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10.2 Documentation Support

10.2.1 Related Documentation

For related documentation see the following:

- Texas Instruments, TI Engineering Evaluation Units vs. MIL-PRF-38535 QML Class V Processing (SLYB235)
- Texas Instruments, Demystifying Type II and Type III Compensators Using Op-Amp and OTA for DC/DC Converters (SLVA662)
- Texas Instruments, TPS7H1121EVM-CVAL Evaluation Module (EVM) (SLVUCX9)
- Texas Instruments, *How to Calculate the Load Pole and ESR Zero When Using Hybrid Output Capacitors* (SLVAE26)

10.3 Receiving Notification of Documentation Updates

To receive notification of documentation updates, navigate to the device product folder on ti.com. Click on *Notifications* to register and receive a weekly digest of any product information that has changed. For change details, review the revision history included in any revised document.

10.4 Support Resources

TI E2E[™] support forums are an engineer's go-to source for fast, verified answers and design help — straight from the experts. Search existing answers or ask your own question to get the quick design help you need.

Linked content is provided "AS IS" by the respective contributors. They do not constitute TI specifications and do not necessarily reflect TI's views; see TI's Terms of Use.

10.5 Trademarks

TI E2E[™] is a trademark of Texas Instruments.

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10.6 Electrostatic Discharge Caution



This integrated circuit can be damaged by ESD. Texas Instruments recommends that all integrated circuits be handled with appropriate precautions. Failure to observe proper handling and installation procedures can cause damage.

ESD damage can range from subtle performance degradation to complete device failure. Precision integrated circuits may be more susceptible to damage because very small parametric changes could cause the device not to meet its published specifications.

10.7 Glossary

TI Glossary

This glossary lists and explains terms, acronyms, and definitions.



11 Revision History

NOTE: Page numbers for previous revisions may differ from page numbers in the current version.

| Cł | hanges from Revision * (May 2024) to Revision A (September 2024) | Page |
|----|--|----------------------------------|
| | Changed TPS7H1121-SP QMLV from Advanced Information to Production Data Removal of "Product Preview" for part number 5962R2320301VXC in the Device Information table | |
| • | Removal of "Product Preview" note for Orderable Part Number 5962R2320301VXC in the Device Optio Table | |
| • | Adjusted Enable threshold values and Programmable Currentl Limit min and max values Added parameter measurment diagrams for Enable Propagation Delay (t _{EN(delay)}) and Soft Start Time (t Updated equation 12 New frequency compensation application section in detailed design procedure | 5 t _{SS}). 15 26 |

12 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.



PACKAGING INFORMATION

| Orderable Device | Status (1) | Package Type | Package Drawing | Pins | Package Qty | Eco Plan (2) | Lead finish/ Ball material | MSL Peak Temp (3) | Op Temp (°C) | Device Marking (4/5) | Samples |
|------------------|---------------|--------------|--------------------|------|----------------|------------------------|-------------------------------|----------------------|--------------|---------------------------|---------|
| | | | | | | | (6) | | | | |
| 5962R2320301VXC | ACTIVE | CFP | HFT | 22 | 25 | RoHS-Exempt | NIAU | N / A for Pkg Type | -55 to 125 | 5962R2320301VXC | Samples |
| | | | | | | & Green | | | | TPS7H1121MHFTV | * |
| TPS7H1121HFT/EM | ACTIVE | CFP | HFT | 22 | 15 | RoHS-Exempt & Green | NIAU | N / A for Pkg Type | 25 to 25 | TPS7H1121HFT EVAL ONLY | Samples |

⁽¹⁾ The marketing status values are defined as follows:

ACTIVE: Product device recommended for new designs.

LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.

NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.

PREVIEW: Device has been announced but is not in production. Samples may or may not be available.

OBSOLETE: TI has discontinued the production of the device.

⁽²⁾ RoHS: TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".

RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.

Green: TI defines "Green" to mean the content of Chlorine (CI) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

⁽³⁾ MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

⁽⁴⁾ There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

⁽⁵⁾ Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

⁽⁶⁾ Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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PACKAGE OPTION ADDENDUM

TEXAS INSTRUMENTS

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27-Nov-2024

TUBE



- B - Alignment groove width

*All dimensions are nominal

| Device | Package Name | Package Type | Pins | SPQ | L (mm) | W (mm) | Τ (μm) | B (mm) |
|-----------------|--------------|--------------|------|-----|--------|--------|--------|--------|
| 5962R2320301VXC | HFT | CFP | 22 | 25 | 506.98 | 32.77 | 9910 | NA |
| TPS7H1121HFT/EM | HFT | CFP | 22 | 15 | 506.98 | 32.77 | 9910 | NA |

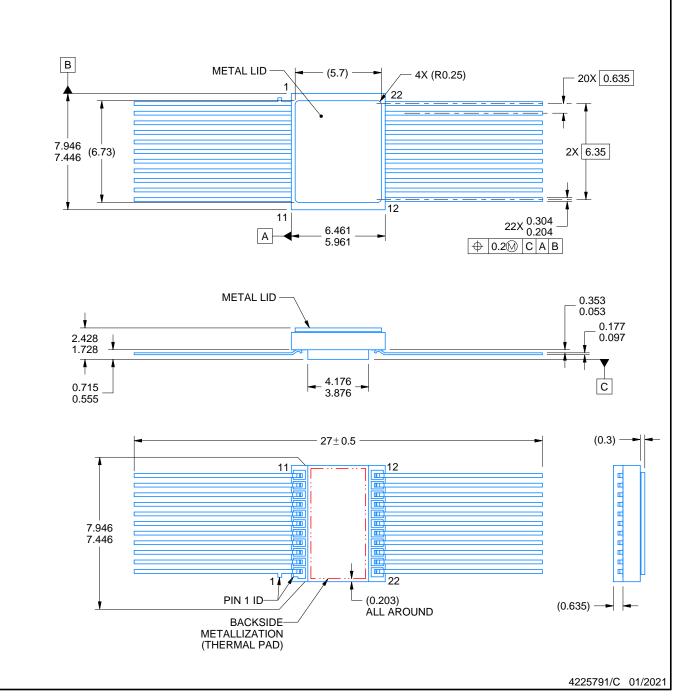
HFT0022A



PACKAGE OUTLINE

CFP - 2.428mm max height

CERAMIC FLATPACK



NOTES:

- 1. All linear dimensions are in millimeters. Any dimensions in parenthesis are for reference only. Dimensioning and tolerancing
- 2. This drawing is subject to change without notice.
 3. This package is hermetically sealed with a metal lid. The lid is not connected to any lead.
- 4. The leads are gold plated.
- 5. Metal lid is connected to backside metalization

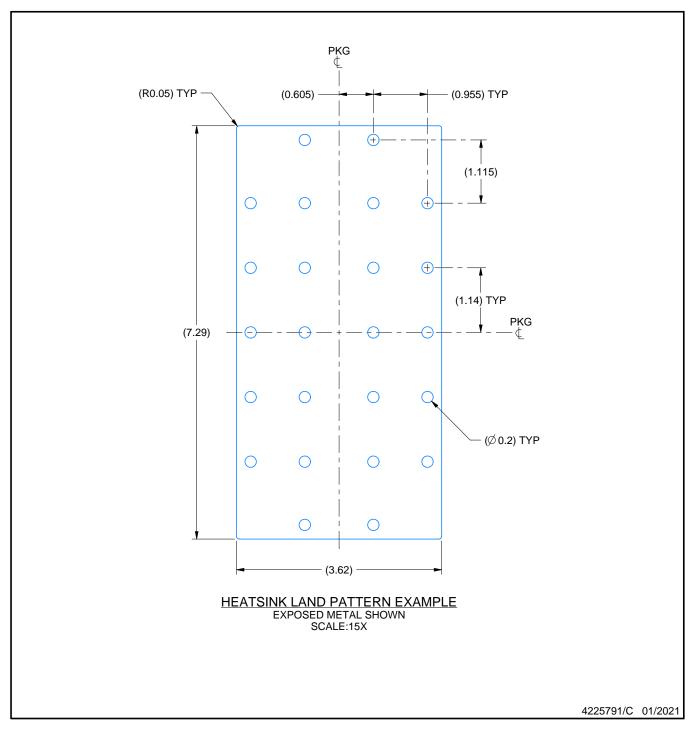


HFT0022A

EXAMPLE BOARD LAYOUT

CFP - 2.428mm max height

CERAMIC FLATPACK





| ER |
|-----|
| JZI |
| JZI |
| JZI |
| _ |

| SCALE | size A | 4225791 | C | PAGE 4 of 4 |
|-------|-----------|---------|---|----------------|
| | | | | |

PWP 24

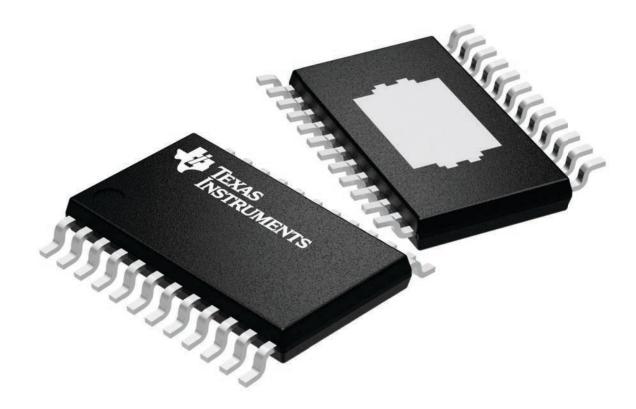
GENERIC PACKAGE VIEW

PowerPAD[™] TSSOP - 1.2 mm max height

PLASTIC SMALL OUTLINE

4.4 x 7.6, 0.65 mm pitch

This image is a representation of the package family, actual package may vary. Refer to the product data sheet for package details.





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